| General Description <br> The 'F350 is a specialized multiplexer that accepts a 4-bit word and shifts it $0,1,2$ or 3 places, as determined by two Select $\left(\mathrm{S}_{0}, \mathrm{~S}_{1}\right)$ inputs. For expansion to longer words, three linking inputs are provided for lower-order bits; thus two packages can shift an 8 -bit word, four packages a 16 -bit word, etc. Shifting by more than three places is accomplished by paralleling the TRI-STATE outputs of different packages and using the Output Enable (OE) inputs as a third Select level. With appropriate interconnections, the 'F350 can perform zero-backfill, sign-extend or end-around (barrel) shift functions. <br> Features <br> - Linking inputs for word expansion <br> - TRI-STATE outputs for extending s |  |  | August 1995 |
| :---: | :---: | :---: | :---: |
| Commercial | Package Number | Package Description |  |
| 74F350PC | N16E | 16-Lead (0.300" Wide) Molded Dual-In-Line |  |
| 74F350SC (Note 1) | M16A | 16-Lead (0.150" Wide) Molded Small Outline, JEDEC |  |
| 74F350SJ (Note 1) | M16D | 16-Lead (0.300" Wide) Molded Small Outline, EIAJ |  |

## Logic Symbols




Connection Diagram


## Unit Loading/Fan Out

| Pin Names | Description | 74F |  |
| :---: | :---: | :---: | :---: |
|  |  | U.L. <br> HIGH/LOW | Input $\mathrm{I}_{\mathrm{IH}} / \mathrm{I}_{\mathrm{IL}}$ Output $\mathrm{IOH}_{\mathrm{OH}} / \mathrm{IOL}_{\mathrm{OL}}$ |
| $\mathrm{S}_{0}, \mathrm{~S}_{1}$ | Select Inputs | 1.0/2.0 | $20 \mu \mathrm{~A} /-1.2 \mathrm{~mA}$ |
| $\mathrm{I}_{-3-13}$ | Data Inputs | 1.0/2.0 | $20 \mu \mathrm{~A} /-1.2 \mathrm{~mA}$ |
| OE | Output Enable Input (Active LOW) | 1.0/2.0 | $20 \mu \mathrm{~A} /-1.2 \mathrm{~mA}$ |
| $\mathrm{O}_{0}-\mathrm{O}_{3}$ | TRI-STATE Outputs | 150/40 (33.3) | $-3 \mathrm{~mA} / 24 \mathrm{~mA}(20 \mathrm{~mA})$ |

## Functional Description

The 'F350 is operationally equivalent to a 4-input multiplexer with the inputs connected so that the select code causes successive one-bit shifts of the data word. This internal connection makes it possible to perform shifts of $0,1,2$ or 3 places on words of any length.
A 4-bit data word is introduced at the $I_{n}$ inputs and is shifted according to the code applied to the select inputs $\mathrm{S}_{0}, \mathrm{~S}_{1}$. Outputs $\mathrm{O}_{0}-\mathrm{O}_{3}$ are TRI-STATE, controlled by an active LOW output enable ( $\overline{\mathrm{OE}}$ ). When $\overline{\mathrm{OE}}$ is LOW, data outputs will follow selected data inputs; when HIGH, the data outputs will be forced to the high impedance state. This feature allows shifters to be cascaded on the same output lines or
to a common bus. The shift function can be logical, with zeros pulled in at either or both ends of the shifting field; arithmetic, where the sign bit is repeated during a shift down; or end around, where the data word forms a continuous loop.

## Logic Equations

$$
\begin{aligned}
& \mathrm{O}_{0}=\overline{\mathrm{S}}_{0} \overline{\mathrm{~S}}_{1} \mathrm{I}_{0}+\mathrm{S}_{0} \overline{\mathrm{~S}}_{1} I_{-1}+\overline{\mathrm{S}}_{0} \mathrm{~S}_{1} \mathrm{I}_{-2}+\mathrm{S}_{0} \mathrm{~S}_{1} \mathrm{I}_{-3} \\
& O_{1}=\bar{S}_{0} \bar{S}_{1} I_{1}+S_{0} \bar{S}_{1} I_{0}+\bar{S}_{0} S_{1} I_{-1}+S_{0} S_{1} I_{-2} \\
& \mathrm{O}_{2}=\overline{\mathrm{S}}_{0} \overline{\mathrm{~S}}_{1} \mathrm{I}_{2}+\mathrm{S}_{0} \overline{\mathrm{~S}}_{1} \mathrm{I}_{1}+\overline{\mathrm{S}}_{0} \mathrm{~S}_{1} \mathrm{I}_{0}+\mathrm{S}_{0} \mathrm{~S}_{1} \mathrm{I}_{-1} \\
& \mathrm{O}_{3}=\overline{\mathrm{S}}_{0} \overline{\mathrm{~S}}_{1} \mathrm{I}_{3}+\mathrm{S}_{0} \overline{\mathrm{~S}}_{1} \mathrm{I}_{2}+\overline{\mathrm{S}}_{0} \mathrm{~S}_{1} 1_{1}+\mathrm{S}_{0} \mathrm{~S}_{1} I_{0}
\end{aligned}
$$

## Truth Table

| Inputs |  |  | Outputs |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\overline{\mathbf{O E}}$ | $\mathbf{S}_{\boldsymbol{1}}$ | $\mathbf{S}_{\mathbf{0}}$ | $\mathbf{O}_{\mathbf{0}}$ | $\mathbf{O}_{\mathbf{1}}$ | $\mathbf{O}_{\mathbf{2}}$ | $\mathbf{O}_{\mathbf{3}}$ |
| H | X | X | Z | Z | Z | Z |
| L | L | L | $\mathrm{I}_{0}$ | $\mathrm{I}_{1}$ | $\mathrm{I}_{2}$ | $\mathrm{I}_{3}$ |
| L | L | H | $\mathrm{I}_{-1}$ | $\mathrm{I}_{0}$ | $\mathrm{I}_{1}$ | $\mathrm{I}_{2}$ |
| L | H | L | $\mathrm{I}_{-2}$ | $\mathrm{I}_{-1}$ | $\mathrm{I}_{0}$ | $\mathrm{I}_{1}$ |
| L | H | H | $\mathrm{I}_{-3}$ | $\mathrm{I}_{-2}$ | $\mathrm{I}_{-1}$ | $\mathrm{I}_{0}$ |

H $=$ HIGH Voltage Level
$L=$ LOW Voltage Level
$\mathrm{X}=$ Immaterial
Z $=$ High Impedance

## Logic Diagram



TL/F/9518-4
Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.


Function Table

|  |  |  |
| :---: | :--- | :--- |
| $\mathbf{S}_{\boldsymbol{1}}$ | $\mathbf{S}_{\mathbf{0}}$ | Shift Function |
| L | L | No Shift |
| L | H | Shift 1 Place |
| H | L | Shift 2 Places |
| H | H | Shift 3 Places |




Absolute Maximum Ratings (Note 1)

Storage Temperature
Ambient Temperature under Bias
Junction Temperature under Bias Plastic
$V_{C C}$ Pin Potential to Ground Pin
Input Voltage (Note 2)
Input Current (Note 2)
e damaged or have its useful life impared. Function he device may these conditions is not implied.
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Voltage Applied to Output
in HIGH State (with $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$ )
Standard Output
-0.5 V to $\mathrm{V}_{\mathrm{CC}}$ -0.5 V to +5.5 V

Current Applied to Output
in LOW State (Max)
twice the rated $\mathrm{l}_{\mathrm{OL}}(\mathrm{mA})$

## Recommended Operating Conditions

| Free Air Ambient Temperature | $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$ |
| :--- | ---: |
| $\quad$ Commercial |  |
| Supply Voltage <br> Commercial | +4.5 V to +5.5 V |

## DC Electrical Characteristics

| Symbol | Parameter | 74F |  |  | Units | $\mathrm{V}_{\mathbf{c c}}$ | Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max |  |  |  |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | 2.0 |  |  | V |  | Recognized as a HIGH Signal |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage |  |  | 0.8 | V |  | Recognized as a LOW Signal |
| $\mathrm{V}_{\mathrm{CD}}$ | Input Clamp Diode Voltage |  |  | -1.2 | V | Min | $\mathrm{I}_{\mathrm{N}}=-18 \mathrm{~mA}$ |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH $74 \mathrm{~F} 10 \% \mathrm{~V}_{\mathrm{CC}}$ <br> Voltage $74 \mathrm{~F} 10 \% \mathrm{~V}_{\mathrm{CC}}$ <br>  $74 \mathrm{~F} 5 \% \mathrm{~V}_{\mathrm{CC}}$ <br>  $74 \mathrm{~F} 10 \% \mathrm{~V}_{\mathrm{CC}}$ | $\begin{aligned} & 2.5 \\ & 2.4 \\ & 2.7 \\ & 2.7 \\ & \hline \end{aligned}$ |  |  | V | Min | $\begin{aligned} & \mathrm{I}_{\mathrm{OH}}=-1 \mathrm{~mA} \\ & \mathrm{I}_{\mathrm{OH}}=-3 \mathrm{~mA} \\ & \mathrm{I}_{\mathrm{OH}}=-1 \mathrm{~mA} \\ & \mathrm{I}_{\mathrm{OH}}=-3 \mathrm{~mA} \end{aligned}$ |
| $\mathrm{V}_{\mathrm{OL}}$ | Output LOW Voltage $74 \mathrm{~F} 10 \% \mathrm{~V}_{\text {CC }}$ |  |  | 0.5 | V | Min | $\mathrm{I}_{\mathrm{OL}}=24 \mathrm{~mA}$ |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current 74F |  |  | 5.0 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{\text {IN }}=2.7 \mathrm{~V}$ |
| $\mathrm{I}_{\mathrm{BVI}}$ | $\begin{aligned} & \text { Input HIGH Current } \quad 74 F \\ & \text { Breakdown Test } \end{aligned}$ |  |  | 7.0 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{\mathrm{IN}}=7.0 \mathrm{~V}$ |
| ${ }^{\text {ICEX }}$ | Output HIGH <br> Leakage Current $74 F$ |  |  | 50 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\text {CC }}$ |
| $\mathrm{V}_{\text {ID }}$ | Input Leakage Test | 4.75 |  |  | V | 0.0 | $\begin{aligned} & \mathrm{I}_{\mathrm{ID}}=1.9 \mu \mathrm{~A} \\ & \text { All Other Pins Grounded } \end{aligned}$ |
| IOD | Output Leakage Circuit Current 74F |  |  | 3.75 | $\mu \mathrm{A}$ | 0.0 | $V_{I O D}=150 \mathrm{mV}$ <br> All Other Pins Grounded |
| IIL | Input LOW Current |  |  | -1.2 | mA | Max | $\mathrm{V}_{\text {IN }}=0.5 \mathrm{~V}$ |
| l OzH | Output Leakage Current |  |  | 50 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{\text {OUT }}=2.7 \mathrm{~V}$ |
| lozL | Output Leakage Current |  |  | -50 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{\text {OUT }}=0.5 \mathrm{~V}$ |
| los | Output Short-Circuit Current | -60 |  | -150 | mA | Max | $\mathrm{V}_{\text {OUT }}=0 \mathrm{~V}$ |
| Izz | Bus Drainage Test |  |  | 500 | $\mu \mathrm{A}$ | 0.0V | $\mathrm{V}_{\text {OUT }}=5.25 \mathrm{~V}$ |
| ICCH | Power Supply Current |  | 34 | 42 | mA | Max | $\mathrm{V}_{\mathrm{O}}=$ HIGH |
| $\mathrm{I}_{\text {CCL }}$ | Power Supply Current |  | 40 | 57 | mA | Max | $\mathrm{V}_{\mathrm{O}}=$ LOW |
| ICCZ | Power Supply Current |  | 40 | 57 | mA | Max | $\mathrm{V}_{\mathrm{O}}=\mathrm{HIGH} \mathrm{Z}$ |

## AC Electrical Characteristics

| Symbol | Parameter |  | 74F |  |  |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\begin{gathered} \mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C} \\ \mathrm{~V}_{\mathrm{CC}}=+5.0 \mathrm{~V} \\ \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF} \\ \hline \end{gathered}$ |  |  | $\begin{gathered} \mathrm{T}_{\mathrm{A}}, \mathrm{~V}_{\mathrm{CC}}=\mathrm{Com} \\ \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF} \end{gathered}$ |  |  |
|  |  | Min | Typ | Max | Min | Max |  |
| $\begin{aligned} & \mathrm{t}_{\mathrm{PLH}} \\ & \mathrm{t}_{\mathrm{PHL}} \end{aligned}$ | Propagation Delay $\mathrm{I}_{\mathrm{n}}$ to $\mathrm{O}_{\mathrm{n}}$ | $\begin{aligned} & 3.0 \\ & 2.5 \end{aligned}$ | $\begin{aligned} & 4.5 \\ & 4.0 \end{aligned}$ | $\begin{aligned} & 6.0 \\ & 5.5 \end{aligned}$ | $\begin{aligned} & 3.0 \\ & 2.5 \end{aligned}$ | $\begin{aligned} & 7.0 \\ & 6.5 \end{aligned}$ | ns |
| $\begin{aligned} & \mathrm{t}_{\mathrm{PLH}} \\ & \mathrm{t}_{\mathrm{PHL}} \\ & \hline \end{aligned}$ | Propagation Delay $\mathrm{S}_{\mathrm{n}} \text { to } \mathrm{O}_{\mathrm{n}}$ | $\begin{aligned} & 4.0 \\ & 3.0 \\ & \hline \end{aligned}$ | $\begin{array}{r} 7.8 \\ 6.5 \\ \hline \end{array}$ | $\begin{gathered} 10.0 \\ 8.5 \\ \hline \end{gathered}$ | $\begin{aligned} & 4.0 \\ & 3.0 \\ & \hline \end{aligned}$ | $\begin{gathered} 13.5 \\ 9.5 \\ \hline \end{gathered}$ | ns |
| $\begin{aligned} & \text { tpZH } \\ & \text { tpZL } \end{aligned}$ | Output Enable Time | $\begin{aligned} & 2.5 \\ & 4.0 \end{aligned}$ | $\begin{aligned} & 5.0 \\ & 7.0 \end{aligned}$ | $\begin{aligned} & 7.0 \\ & 9.0 \end{aligned}$ | $\begin{aligned} & 2.5 \\ & 4.0 \end{aligned}$ | $\begin{gathered} 8.0 \\ 10.0 \end{gathered}$ | ns |
| $\begin{aligned} & \mathrm{t}_{\mathrm{PHZ}} \\ & \mathrm{t}_{\mathrm{PLLZ}} \end{aligned}$ | Output Disable Time | $\begin{aligned} & 2.0 \\ & 2.0 \end{aligned}$ | $\begin{aligned} & 3.9 \\ & 4.0 \end{aligned}$ | $\begin{aligned} & 5.5 \\ & 5.5 \end{aligned}$ |  | $\begin{aligned} & 6.5 \\ & 7.5 \end{aligned}$ |  |

## Ordering Information

The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:


Physical Dimensions inches (millimeters)


16-Lead (0.150" Wide) Molded Small Outline Package, JEDEC (S)
NS Package Number M16A


16-Lead ( $0.300^{\prime \prime}$ Wide) Molded Small Outline Package, EIAJ (SJ)
NS Package Number M16D

Physical Dimensions inches (millimeters) (Continued)


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| :---: | :---: | :---: | :---: |

